

Applicable for automotive interior light

809 Series Ice Blue

EMIBT809-S / STIBZ12AE



Product Brief

Description

- This White Colored surface-mount LED comes in standard package dimension. Package Size: 2.2x1.4x1.3mm
- It has a substrate made up of a molded plastic reflector sitting on top of a lead frame.
- The die is attached within the reflector cavity and the cavity is encapsulated by silicone.
- The package design coupled with careful selection of component materials allow these products to perform with high reliability.

Features and Benefits

- White PLCC2 Ice Blue Color
- ESD min 2kV
- MSL 2a Level
- Viewing angle 120°
- AEC-Q101 Qualified
- RoHS compliant

Key Applications

- Interior automotive
- Electronic sign and signals
- Electrical Equipment, Home appliance

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Performance Characteristics

Table 1. Electro Optical Characteristics, $I_F=20\text{mA}$, $T_J = 25^\circ\text{C}$, RH30%

Parameter	Symbol	Value			Unit
		Min.	Typ.	Max.	
Forward Voltage ^[1]	V_F	2.4	3.1	3.8	V
Luminous Intensity ^{[2] [1]}	I_V	450	675	900	mcd
Luminous Flux	Φ_V		2025		mlm
Color Coordinate ^{[3] [1]}	X		0.195		-
	Y		0.280		-
Viewing Angle ^[4]	$2\theta_{1/2}$		120		deg.
Optical Efficiency	η_{op}		33		lm/W
Thermal resistance ^[5]	$R_{th JA}$		530		$^\circ\text{C} / \text{W}$
	$R_{th JS}$		280		$^\circ\text{C} / \text{W}$
Temperature coefficient of V_F $-10^\circ\text{C} \leq T \leq 100^\circ\text{C}$	TC_V		-2.82		$\text{mV}/^\circ\text{C}$
Temperature coefficient of X $-10^\circ\text{C} \leq T \leq 100^\circ\text{C}$	TC_x		-0.16		$10^{-3}/^\circ\text{C}$
Temperature coefficient of Y $-10^\circ\text{C} \leq T \leq 100^\circ\text{C}$	TC_y		-0.30		$10^{-3}/^\circ\text{C}$

Notes :

- (1) Tolerance : $V_F : \pm 0.1\text{V}$, $I_V : \pm 7\%$, $x, y : \pm 0.005$
- (2) The luminous intensity I_V was measured at the peak of the spatial pattern which may not be aligned with the mechanical axis of the LED package.
- (3) Correlated Color is derived from the CIE 1931 Chromaticity diagram.
- (4) $\Theta_{1/2}$ is the off-axis where the luminous intensity is 1/2 of the peak intensity
- (5) Thermal resistance = $R_{th JA}$: Junction/ambient , $R_{th JS}$: Junction/solder point
Pad design for improved heat dissipation : Cu-area > Cu 16mm² per pad, FR4, t=1.6mm
- (6) Not designed for reverse operation

Performance Characteristics

Table 2. Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Power Dissipation ($T_a=25^\circ\text{C}$)	P_d	118	mW
Forward Current ($T_a=25^\circ\text{C}$)	I_F	30	mA
Peak Forward Current ($t \leq 10\mu\text{sec}, D \leq 5/1000, T_a=25^\circ\text{C}$)	I_{FM}	300	mA
Operating Temperature	T_{opr}	-40 ~ +110	$^\circ\text{C}$
Storage Temperature	T_{stg}	-40 ~ +110	$^\circ\text{C}$
Junction Temperature	T_j	125	$^\circ\text{C}$
Soldering Temperature	T_{sld}	Reflow Soldering : 260 $^\circ\text{C}$ for 10sec. Hand Soldering : 315 $^\circ\text{C}$ for 4sec.	
ESD (R=1.5k Ω , C= 100pF) ^[1]		Min 2	kV

Notes :

(1) A zener diode is included for ESD Protection.

- LED's properties might be different from suggested values like above and below tables if operation condition will be exceeded our parameter range. Care is to be taken that power dissipation does not exceed the absolute maximum rating of the product.
- All measurements were made under the standardized environment of Seoul Semiconductor.

Characteristics Graph

Fig 1. Color Spectrum, $I_F = 20\text{mA}$, $T_j = 25^\circ\text{C}$, RH30%

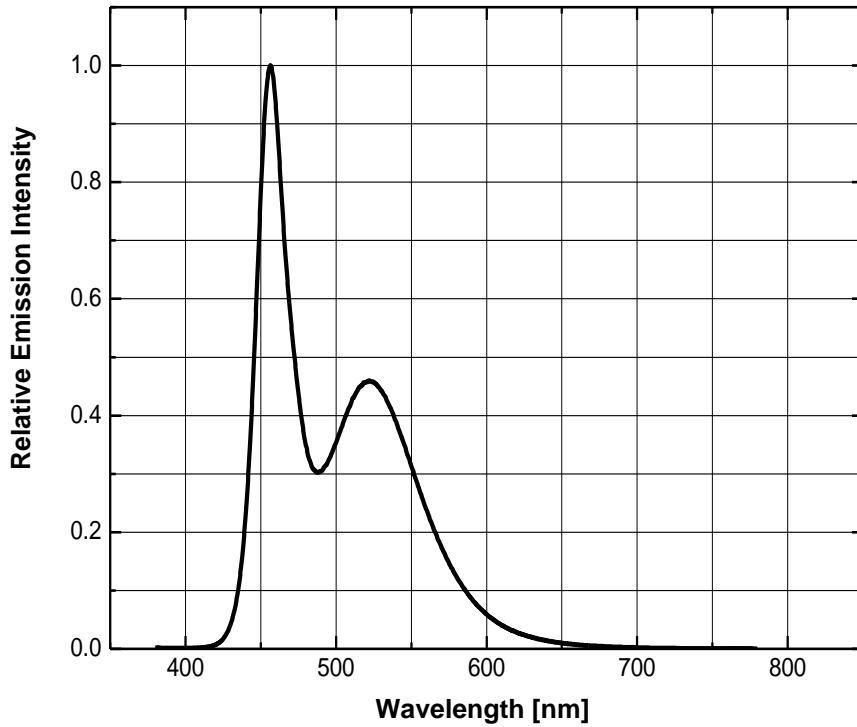
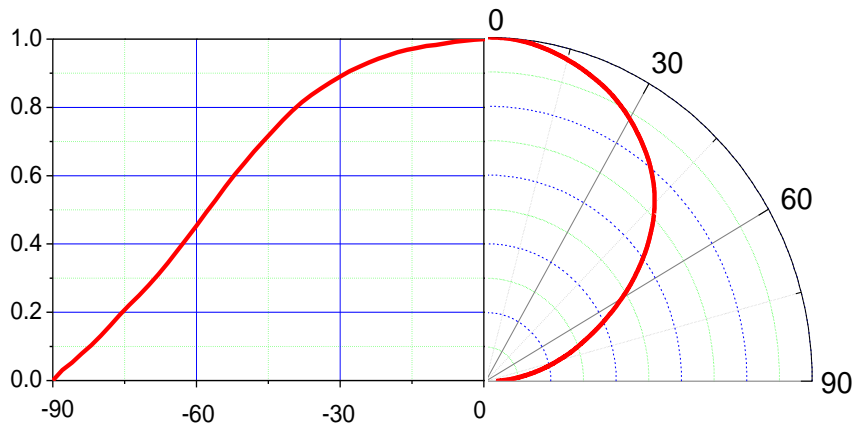


Fig 2. Viewing Angle Distribution, $I_F = 20\text{mA}$



Characteristics Graph

Fig 3. Forward Voltage vs. Forward Current, $T_j = 25^\circ\text{C}$

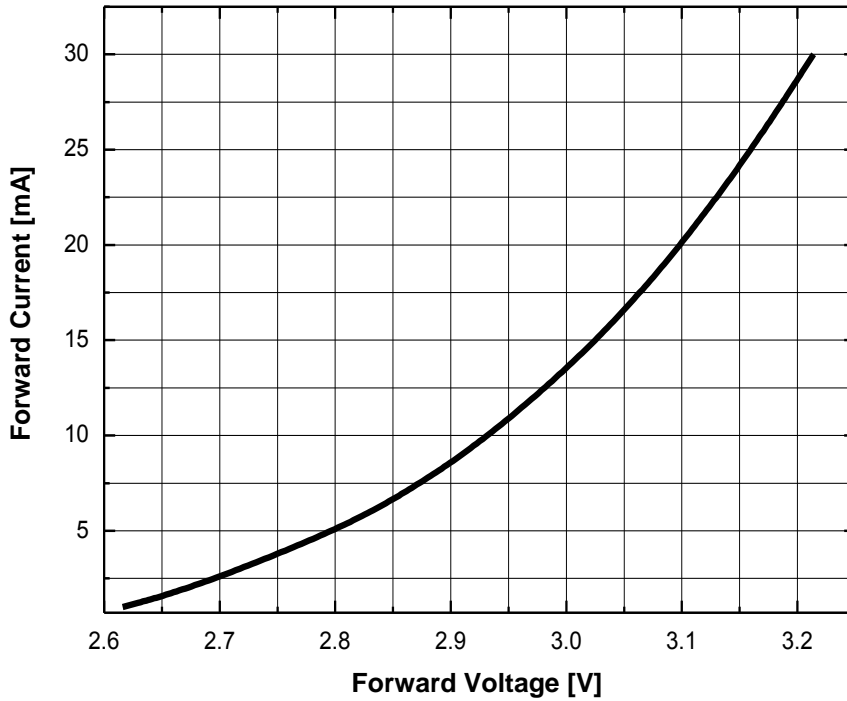
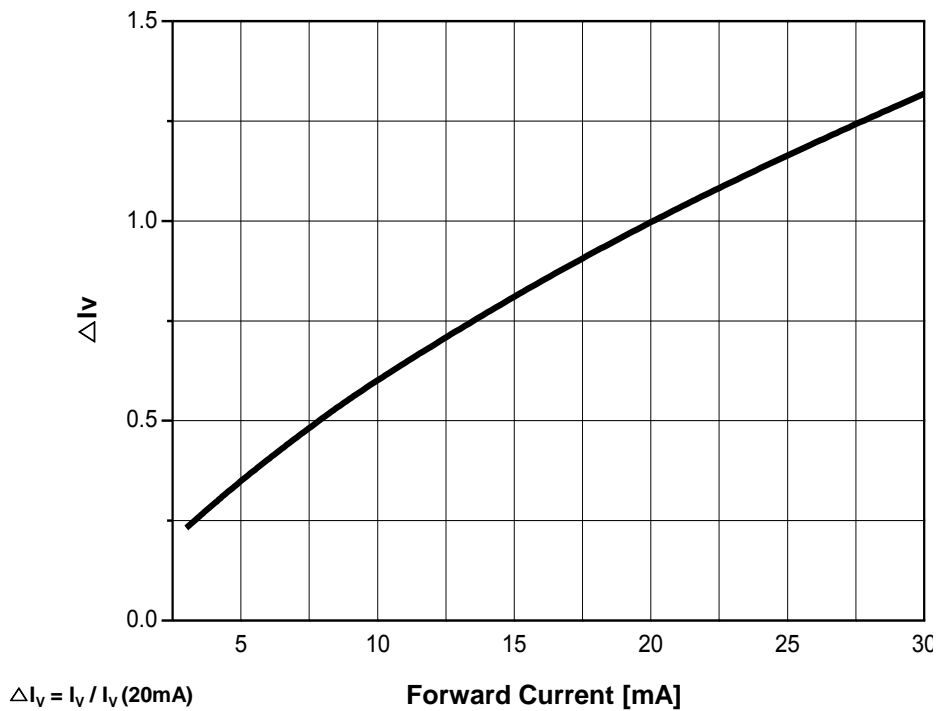
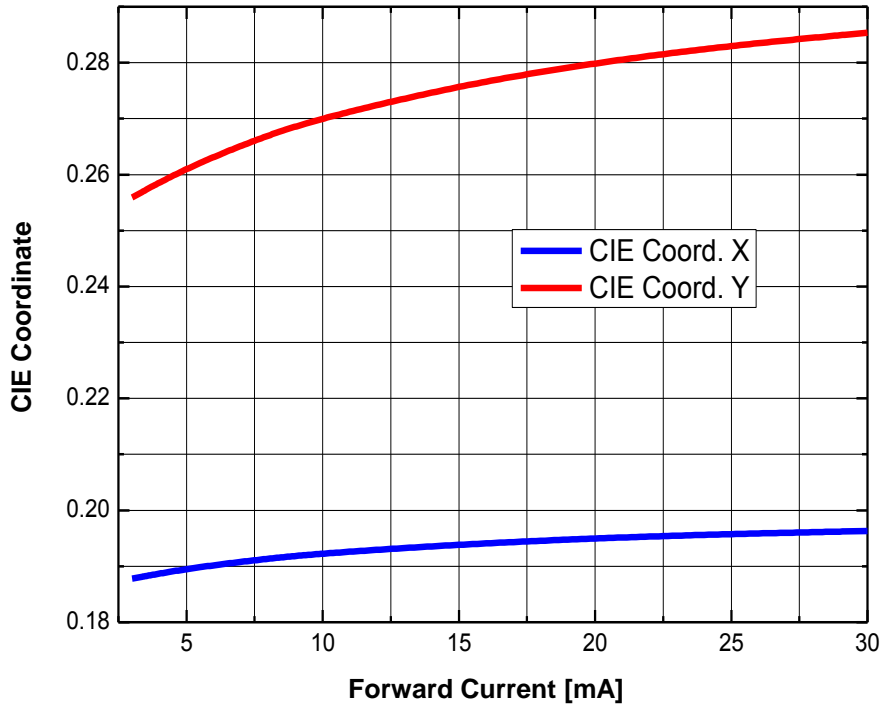


Fig 4. Forward Current vs. Relative Luminous Intensity, $T_j = 25^\circ\text{C}$



Characteristics Graph

Fig 5. Forward Current vs. CIE X, Y Shift, $T_j = 25^\circ\text{C}$



Characteristics Graph

Fig 6. Relative Light Output vs. Junction Temperature, $I_F = 20\text{mA}$

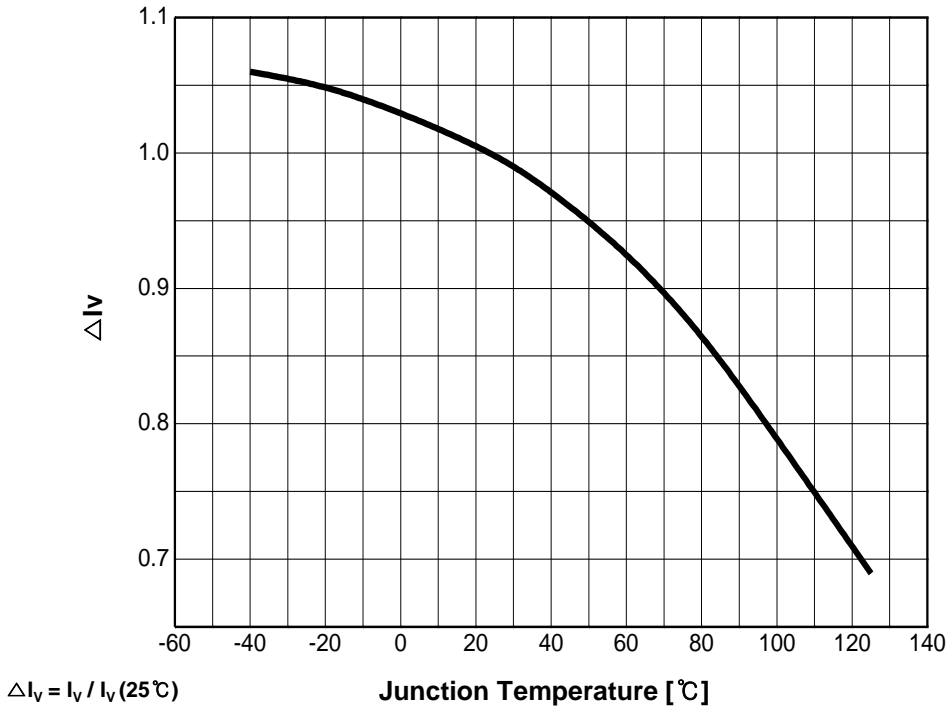
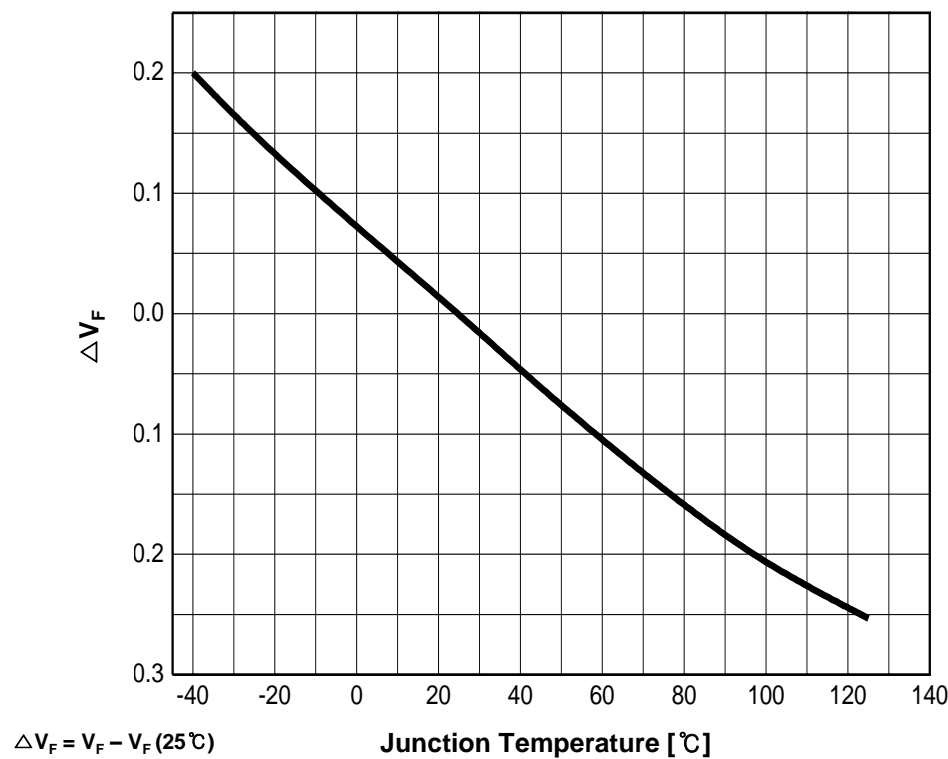
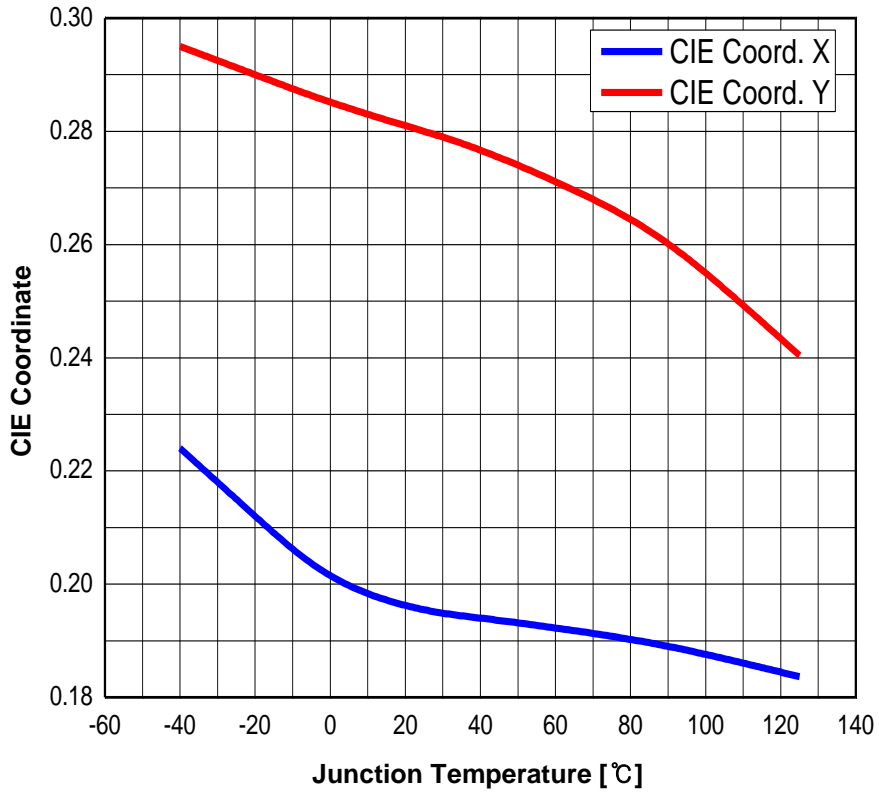


Fig 7. Junction Temperature vs. Forward Voltage Shift, $I_F = 20\text{mA}$



Characteristics Graph

Fig 8. Chromaticity Coordinate vs. Junction Temperature, $I_F = 20\text{mA}$



Characteristics Graph

Fig 9. Maximum Forward Current vs. Temperature

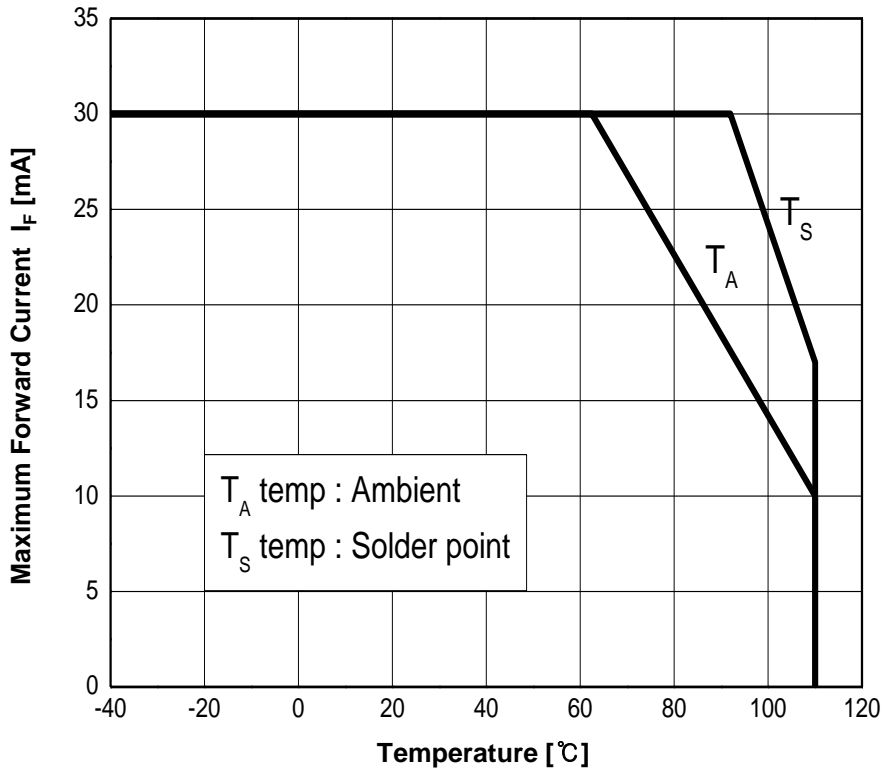
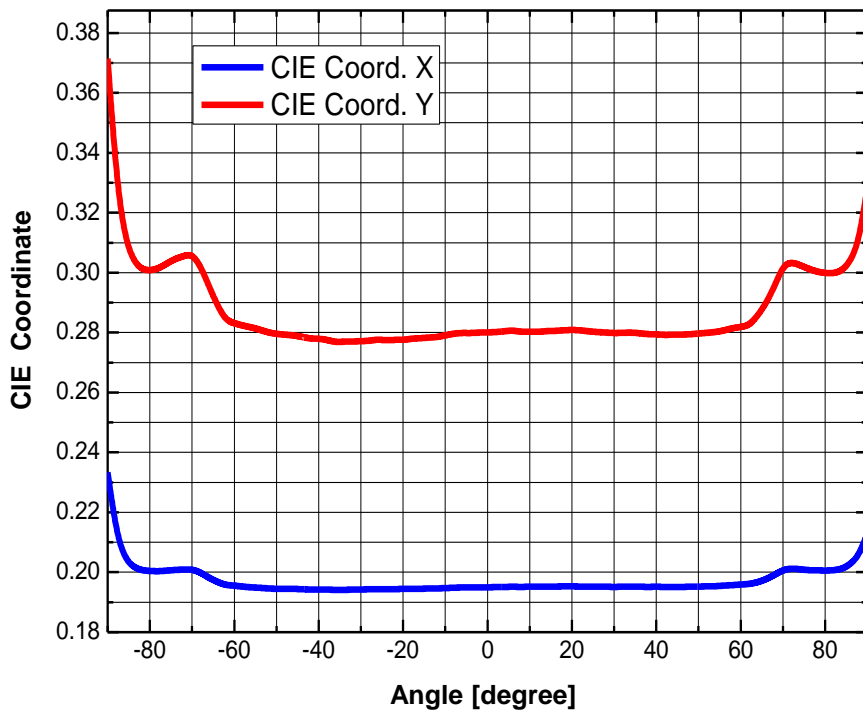


Fig 10. Color. vs. Viewing Angle, $T_a = 25^\circ\text{C}$, $I_F = 20\text{mA}$



Characteristics Graph

Fig 11. Maximum Forward Current vs. Duty Ratio, $T_j = 25^\circ\text{C}$

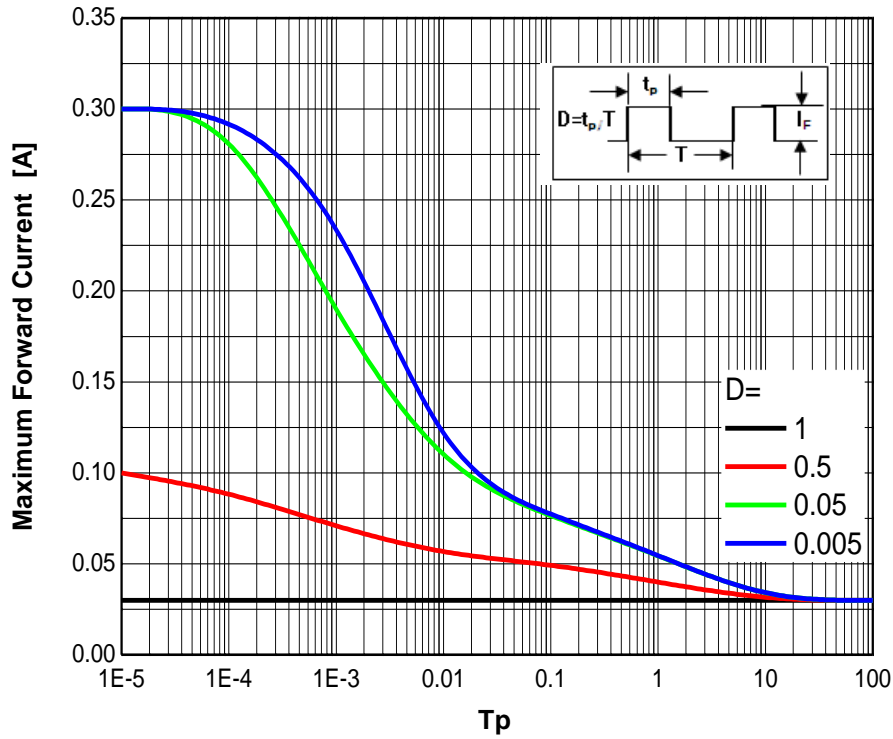
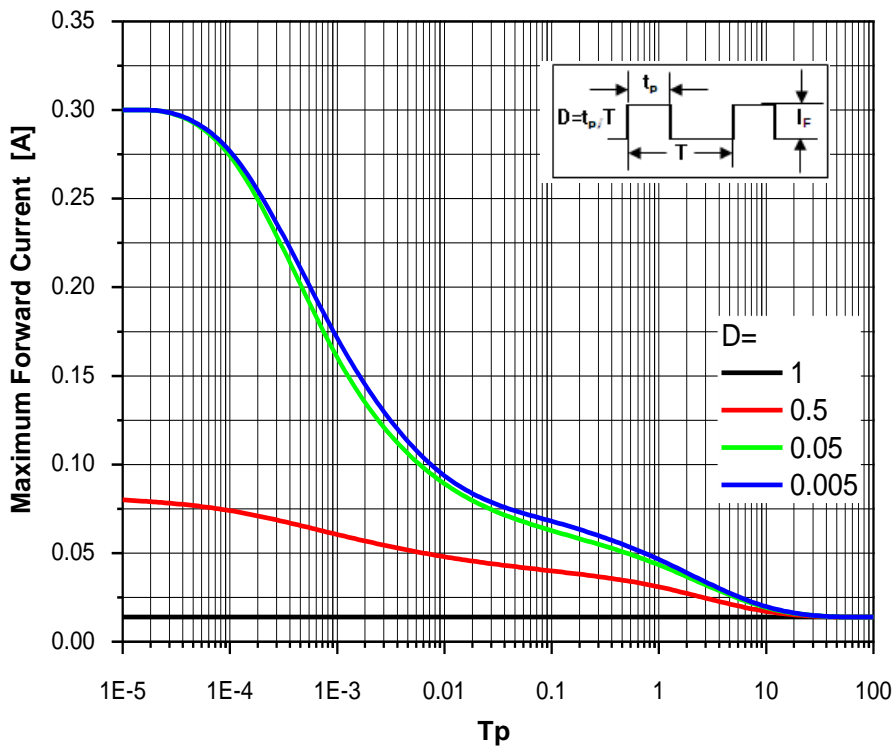


Fig 12. Maximum Forward Current vs. Duty Ratio, $T_a = 85^\circ\text{C}$



Color Bin Structure

Table 3. Bin Code description, $T_j=25^{\circ}\text{C}$, $I_F=20\text{mA}$

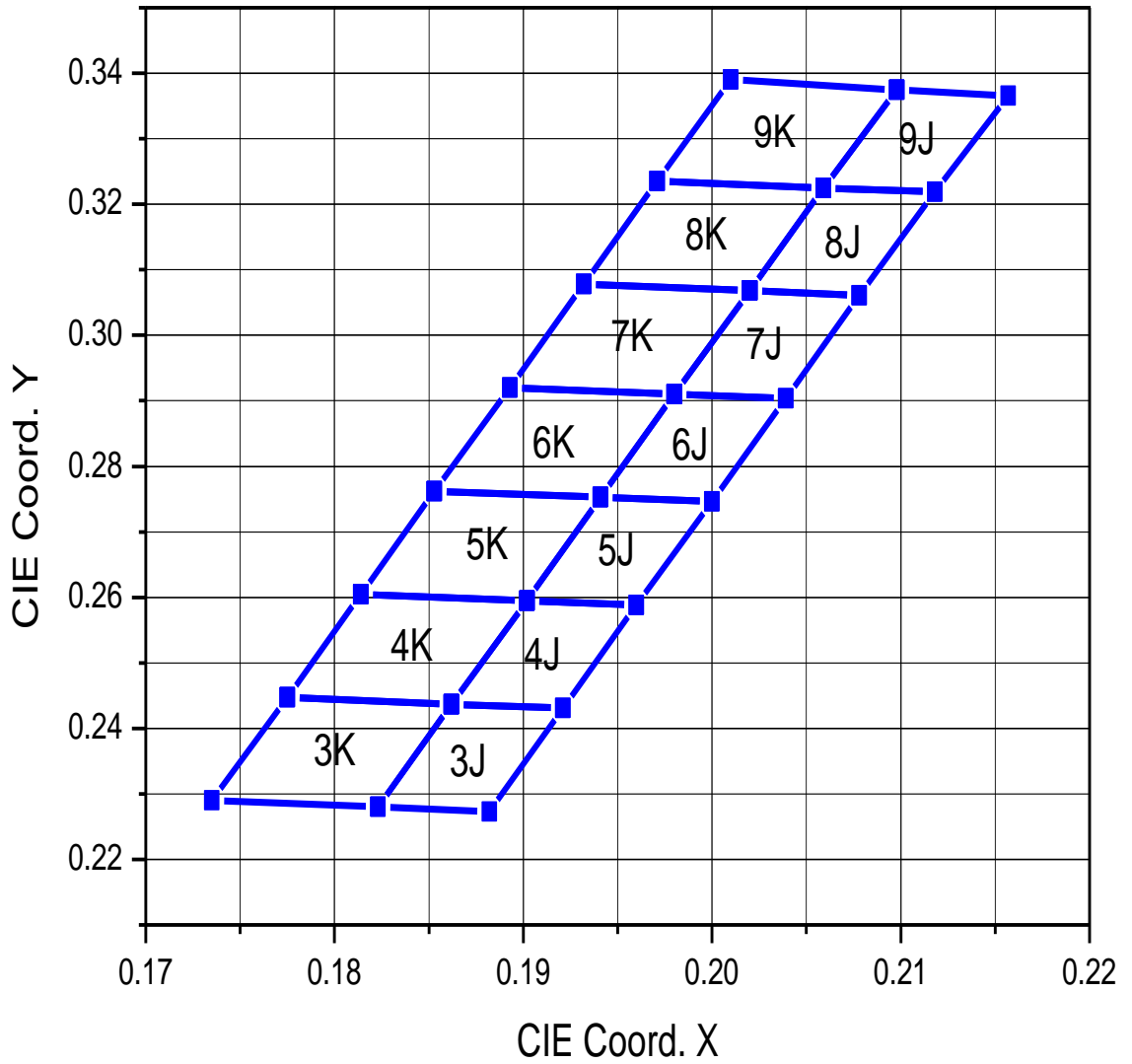
Part Number	Luminous Intensity (mcd)			Color Chromaticity Coordinate	Forward Voltage (V)		
	Bin Code	Min.	Max.		Bin Code	Min.	Max.
EMIBT809-S	U1	450	560	Refer to page 13,14	A	2.4	3.1
	U2	560	710		B	3.1	3.8
	V1	710	900				

***Notes :**

(1) All measurements were made under the standardized environment of Seoul Semiconductor
 In order to ensure availability, single color rank will not be orderable.

Color Bin Structure

CIE Chromaticity Diagram, $I_F = 20\text{mA}$, $T_j = 25^\circ\text{C}$



***Notes :**

•Measurement Uncertainty of the Color Coordinates : ± 0.005

Color Bin Structure

CIE Chromaticity Diagram, $I_F = 20\text{mA}$, $T_j = 25^\circ\text{C}$

3K		3J		4K		4J	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.1775	0.2447	0.1862	0.2437	0.1814	0.2605	0.1902	0.2595
0.1862	0.2437	0.1921	0.2431	0.1902	0.2595	0.1960	0.2588
0.1823	0.2280	0.1882	0.2273	0.1862	0.2437	0.1921	0.2431
0.1735	0.2290	0.1823	0.2280	0.1775	0.2447	0.1862	0.2437
5K		5J		6K		6J	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.1853	0.2762	0.1941	0.2753	0.1893	0.2920	0.1980	0.2910
0.1941	0.2753	0.2000	0.2746	0.1980	0.2910	0.2039	0.2904
0.1902	0.2595	0.1960	0.2588	0.1941	0.2753	0.2000	0.2746
0.1814	0.2605	0.1902	0.2595	0.1853	0.2762	0.1941	0.2753
7K		7J		8K		8K	
CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y	CIE X	CIE Y
0.1932	0.3078	0.2020	0.3068	0.1971	0.3235	0.2059	0.3225
0.2020	0.3068	0.2078	0.3061	0.2059	0.3225	0.2118	0.3219
0.1980	0.2910	0.2039	0.2904	0.2020	0.3068	0.2078	0.3061
0.1893	0.2920	0.1980	0.2910	0.1932	0.3078	0.2020	0.3068
9K		9J					
CIE X	CIE Y	CIE X	CIE Y				
0.2010	0.3390	0.2098	0.3375				
0.1971	0.3235	0.2059	0.3225				
0.2059	0.3225	0.2118	0.3219				
0.2098	0.3375	0.2157	0.3366				

***Notes :**

 •Measurement Uncertainty of the Color Coordinates : ± 0.005

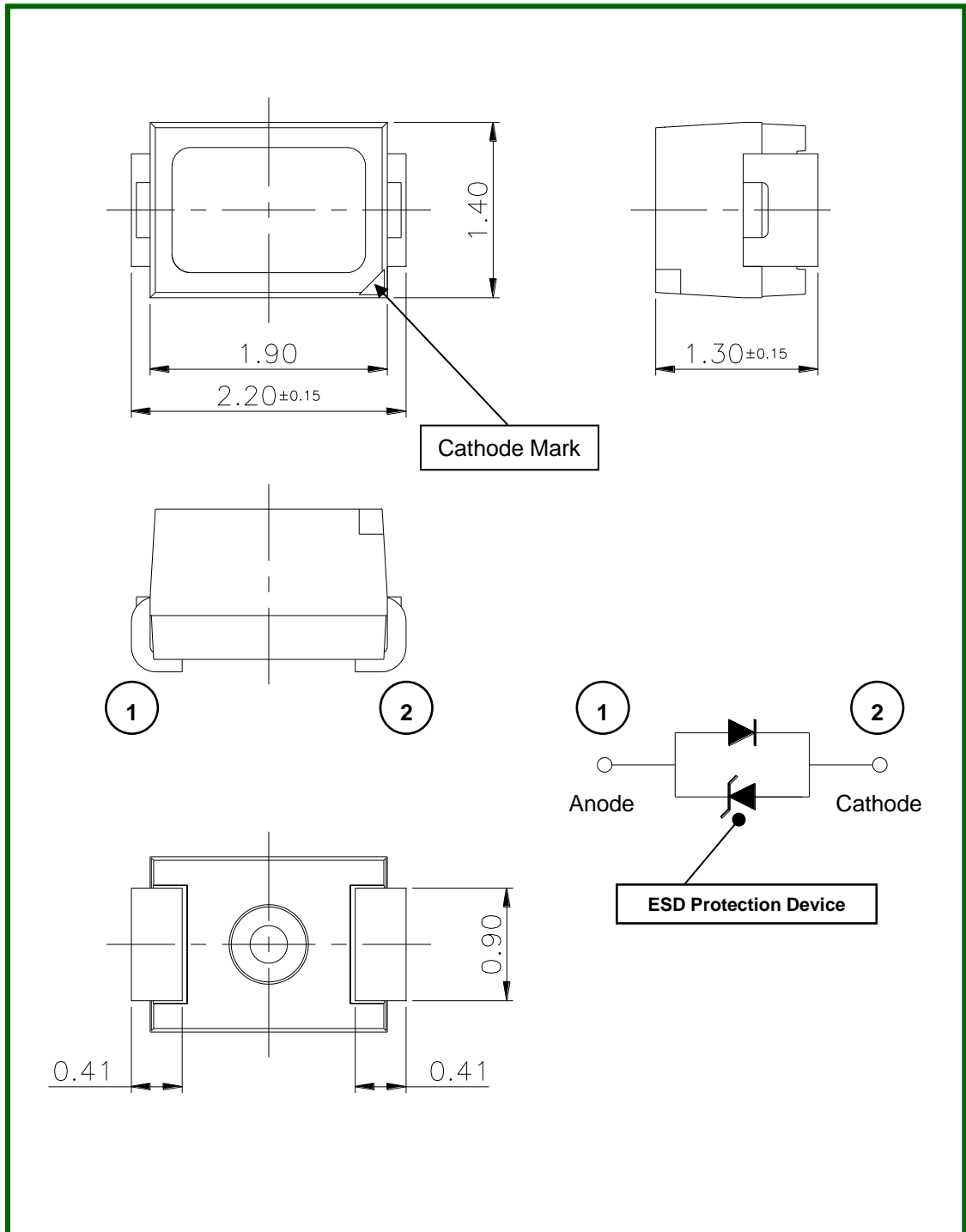
Reliability Test

Test Item	Standard Test Method	Test Condition	Duration / Cycle	Number Of Test
External Visual	JESD22 B-101	Visual inspection	-	77
D.P.A	AEC-Q101-004	Random Sample H3TRB,HAST,TC	-	5
Vibration	JESD22 B-103	0.06 inch displacement, 20 to 100 Hz, 50 g 100 Hz to 2kHz,	4 times	30
ESD	JESD22 A-114	Human-body mode, R=1.5k Ω , C = 100pF	3 times Negative/ Positive	30
Physical Dimension	JESD22 B-100	Verify physical dimensions against device mechanical drawing	3 times	30
Mechanical Shock	JESD22 B-104	1500 g's for 0.5 ms, 5 blows, 3 orientations	3 times	30
Parametric Verification	JESD22 A-108	25°C, 1000 hours @30mA	1000hrs	77
Temperature cycling	JESD22 A-104	T _c = -40° ~ 100°C, 30 min. dwell, 5 min transfer, 1000 cycles	1000hrs	77
Power Temperature Cycle	JESD22 A-105	T _a =-40°C ~85°C, I _f =21mA, 20 min dwell / 20 min transition (1 hour cycle), 2 min ON / 2 min OFF	1000hrs	77
High Humidity High Temp. Operating Life	JESD22 A-101	85°C/85% RH, @21mA	1000hrs	77
High Temperature Operating Life	JESD22 A-108C	T _a = 100°C, I _f =14mA	1000hrs	77
Low Temperature Operating Life	JESD22 A-108C	T _a = -40°C, I _f = 30mA	1000hrs	77
Low Temperature Storage Life	JESD22 A-119	T _a =-40°C, non-operating	1000hrs	77
High Temperature Storage Life	JESD22 A-103B	T _a =100°C, non-operating	1000hrs	77
Thermal Shock	JESD22 A-104	-40°C ~ 100°C, 20 min. dwell, <10 second transfer, 1000 cycles	1000hrs	77

Criteria for Judging the Damage

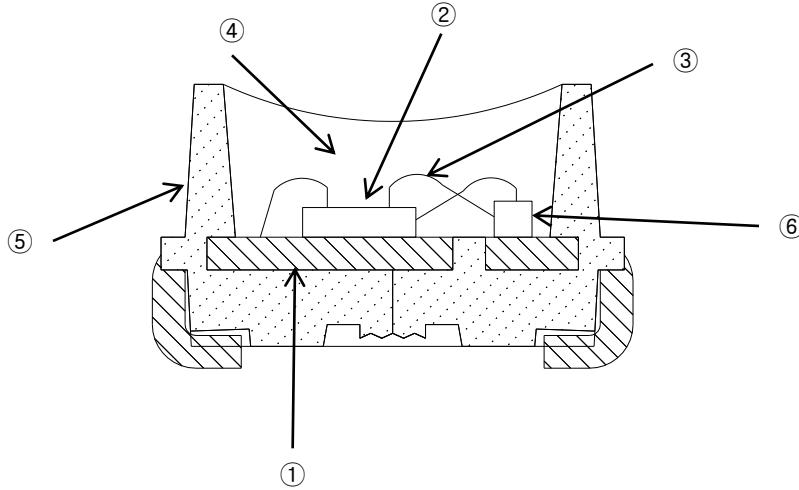
Item	Symbol	Condition	Criteria for Judgment	
			MIN	MAX
Forward Voltage	V _F	I _F =20mA	-	Initial × 1.2
Luminous Intensity	I _V	I _F =20mA	Initial × 0.8	-

Mechanical Dimensions



- (1) All dimensions are in millimeters.
- (2) Scale : none
- (3) Undefined tolerance is ±0.1mm

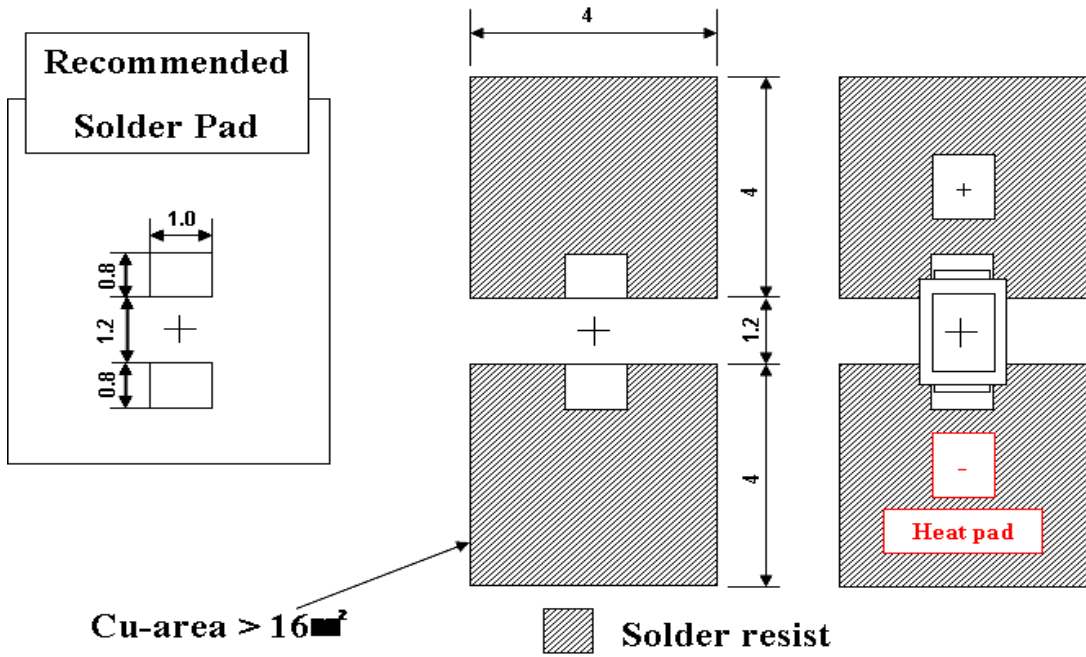
Material Structure



Parts No.	Name	Description	Materials
①	LEAD FRAME	Metal	Copper Alloy (Gold Plated)
②	Chip Source	Blue LED	GaN on Sapphire
③	Wire	Metal	Gold Wire
④	Encapsulation	Silicone	+Phosphor
⑤	Body	PPA	Heat-resistant Polymer
⑥	ESD Protection Device	Si	-

Recommended Solder Pad

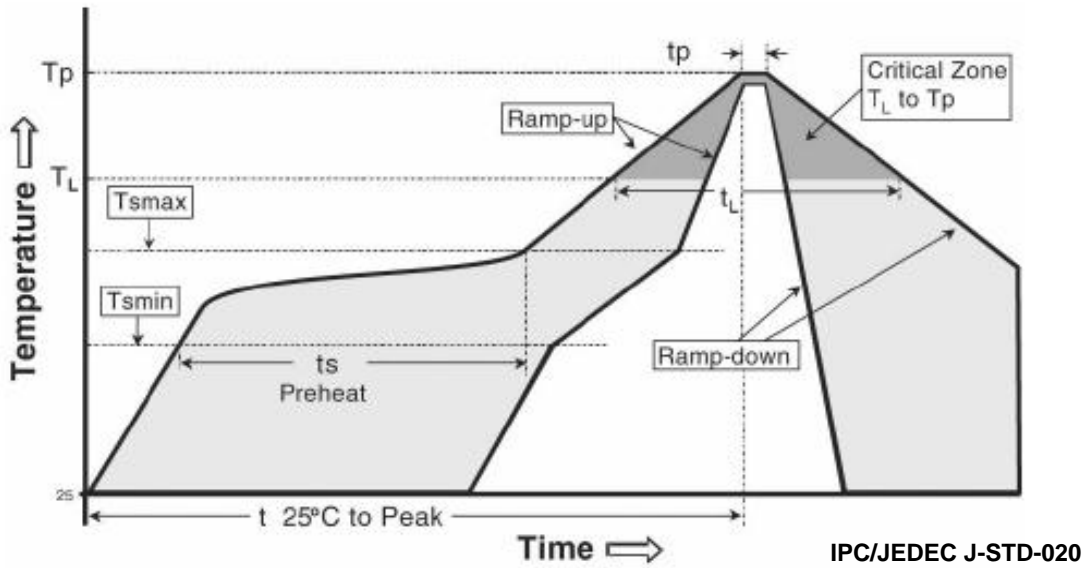
Pad design for
Improved heat dissipation



Notes :

- (1) All dimensions are in millimeters.
- (2) Scale : none
- (3) This drawing without tolerances are for reference only.
- (4) Undefined tolerance is ±0.1mm.

Reflow Soldering Characteristics

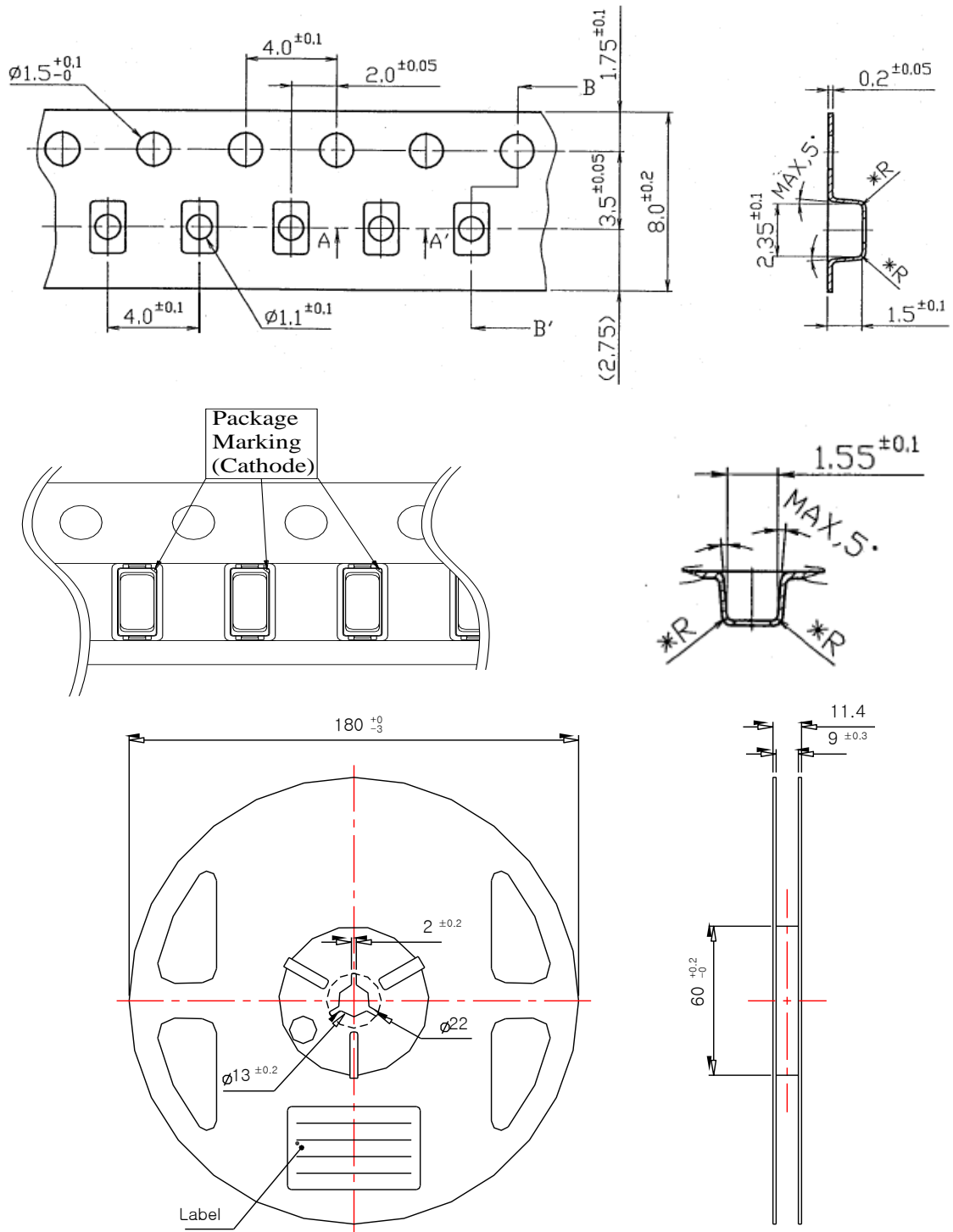


Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Average ramp-up rate (T _{smax} to T _p)	3° C/second max.	3° C/second max.
Preheat - Temperature Min (T _{smin}) - Temperature Max (T _{smax}) - Time (T _{smin} to T _{smax}) (ts)	100 °C 150 °C 60-120 seconds	150 °C 200 °C 60-180 seconds
Time maintained above: - Temperature (T _L) - Time (t _L)	183 °C 60-150 seconds	217 °C 60-150 seconds
Peak Temperature (T _p)	215 °C	260 °C
Time within 5°C of actual Peak Temperature (tp) ²	10-30 seconds	20-40 seconds
Ramp-down Rate	6 °C/second max.	6 °C/second max.
Time 25°C to Peak Temperature	6 minutes max.	8 minutes max.

Caution

- (1) Reflow soldering is recommended not to be done more than two times. In the case of more than 24 hours passed soldering after first, LEDs will be damaged.
- (2) Repairs should not be done after the LEDs have been soldered. When repair is unavoidable, suitable tools must be used.
- (3) Die slug is to be soldered.
- (4) When soldering, do not put stress on the LEDs during heating.
- (5) After soldering, do not warp the circuit board.

Emitter Tape & Reel Packaging



(Tolerance: ± 0.2 , Unit: mm)

(1) Quantity : Max 2,500pcs/Reel

(2) Cumulative Tolerance : Cumulative Tolerance/10 pitches to be ± 0.2 mm

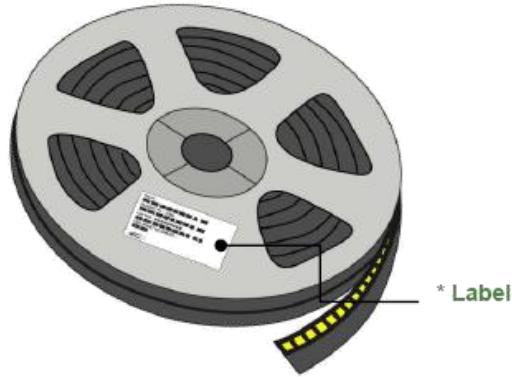
(3) Adhesion Strength of Cover Tape

Adhesion strength to be 0.1-0.7N when the cover tape is turned off from the carrier tape at the angle of 10° to the carrier tape.

(4) Package : P/N, Manufacturing data Code No. and Quantity to be indicated on a damp proof Package.

Emitter Tape & Reel Packaging

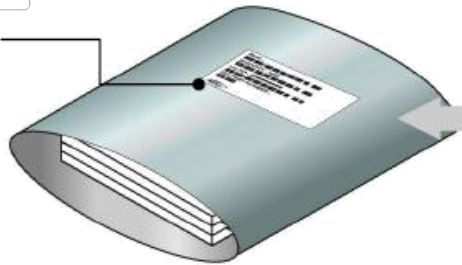
Reel



Aluminum Bag



* Label



Humidity Indicator

Desiccant

Outer Box



* Label

Product Nomenclature

Table 4. Part Numbering System : X₁X₂X₃X₄X₅X₆X₇X₈-X₉

Part Number Code	Description	Part Number	Value
X ₁	Company	E	SSC
X ₂ X ₃ X ₄	Color	MIB	Middle Ice Blue
X ₅	Package Type	T	Top View
X ₆ X ₇ X ₈	Package Series	809	809 Series
X ₉	Encapsulating Type	S	Silicone Molded

Table 5. Lot Numbering System : Y₁Y₂Y₃Y₄Y₅Y₆Y₇Y₈Y₉Y₁₀-Y₁₁Y₁₂Y₁₃Y₁₄Y₁₅Y₁₆Y₁₇

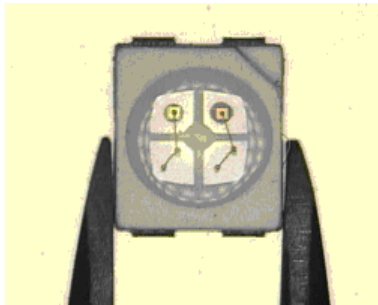
Lot Number Code	Description	Lot Number	Value
Y ₁ Y ₂	Year		
Y ₃	Month		
Y ₄ Y ₅	Day		
Y ₆	Top View LED Series		
Y ₇ Y ₈ Y ₉ Y ₁₀	Mass Order		
Y ₁₁ Y ₁₂ Y ₁₃ Y ₁₄ Y ₁₅ Y ₁₆ Y ₁₇	Internal Number		

Handling of Silicone Resin for LEDs

(1) During processing, mechanical stress on the surface should be minimized as much as possible. Sharp objects of all types should not be used to pierce the sealing compound.



(2) In general, LEDs should only be handled from the side. By the way, this also applies to LEDs without a silicone sealant, since the surface can also become scratched.



(3) When populating boards in SMT production, there are basically no restrictions regarding the form of the pick and place nozzle, except that mechanical pressure on the surface of the resin must be prevented. This is assured by choosing a pick and place nozzle which is larger than the LED's reflector area.

(4) Silicone differs from materials conventionally used for the manufacturing of LEDs. These conditions must be considered during the handling of such devices. Compared to standard encapsulants, silicone is generally softer, and the surface is more likely to attract dust.

As mentioned previously, the increased sensitivity to dust requires special care during processing. In cases where a minimal level of dirt and dust particles cannot be guaranteed, a suitable cleaning solution must be applied to the surface after the soldering of components.

(5) Seoul Semiconductor suggests using isopropyl alcohol for cleaning. In case other solvents are used, it must be assured that these solvents do not dissolve the package or resin. Ultrasonic cleaning is not recommended. Ultrasonic cleaning may cause damage to the LED.

(6) Please do not mold this product into another resin (epoxy, urethane, etc) and do not handle this product with acid or sulfur material in sealed space.

Precaution for Use

(1) Storage

To avoid the moisture penetration, we recommend store in a dry box with a desiccant.

The recommended storage temperature range is 5 °C to 30 °C and a maximum humidity of RH50%.

(2) Use Precaution after Opening the Packaging

Use proper SMT techniques when the LED is to be soldered dipped as separation of the lens may affect the light output efficiency.

Pay attention to the following:

a. Recommend conditions after opening the package

- Sealing

- Temperature : 5 ~ 40 °C Humidity : less than RH30%

b. If the package has been opened more than 4 week(MSL_2a) or the color of the desiccant changes, components should be dried for 10-12hr at 60±5 °C

(3) Do not apply mechanical force or excess vibration during the cooling process to normal temperature after soldering.

(4) Do not rapidly cool device after soldering.

(5) Components should not be mounted on warped (non coplanar) portion of PCB.

(6) Radioactive exposure is not considered for the products listed here in.

(7) Gallium arsenide is used in some of the products listed in this publication.

These products are dangerous if they are burned or shredded in the process of disposal.

It is also dangerous to drink the liquid or inhale the gas generated by such products when chemically disposed of.

(8) This device should not be used in any type of fluid such as water, oil, organic solvent and etc.

When washing is required, IPA (Isopropyl Alcohol) should be used.

(9) When the LEDs are in operation the maximum current should be decided after measuring the package temperature.

(10) LEDs must be stored properly to maintain the device. If the LEDs are stored for 3 months or more after being shipped from SSC, a sealed container with a nitrogen atmosphere should be used for storage.

Precaution for Use

- (11) The appearance and specifications of the product may be modified for improvement without notice.
- (12) Long time exposure of sunlight or occasional UV exposure will cause lens discoloration.
- (13) VOCs (Volatile organic compounds) emitted from materials used in the construction of fixtures can penetrate silicone encapsulants of LEDs and discolor when exposed to heat and photonic energy. The result can be a significant loss of light output from the fixture. Knowledge of the properties of the materials selected to be used in the construction of fixtures can help prevent these issues.
- (14) Attaching LEDs, do not use adhesives that outgas organic vapor.
- (15) The driving circuit must be designed to allow forward voltage only when it is ON or OFF.
If the reverse voltage is applied to LED, migration can be generated resulting in LED damage.
- (16) Similar to most Solid state devices;
LEDs are sensitive to Electro-Static Discharge (ESD) and Electrical Over Stress (EOS).
Below is a list of suggestions that Seoul Semiconductor purposes to minimize these effects.

a. ESD (Electro Static Discharge)

Electrostatic discharge (ESD) is defined as the release of static electricity when two objects come into contact. While most ESD events are considered harmless, it can be an expensive problem in many industrial environments during production and storage. The damage from ESD to LEDs may cause the product to demonstrate unusual characteristics such as:

- Increase in reverse leakage current lowered turn-on voltage
- Abnormal emissions from the LED at low current

The following recommendations are suggested to help minimize the potential for an ESD event. One or more recommended work area suggestions:

- Ionizing fan setup
- ESD table/shelf mat made of conductive materials
- ESD safe storage containers

One or more personnel suggestion options:

- Antistatic wrist-strap
- Antistatic material shoes
- Antistatic clothes

Environmental controls:

- Humidity control (ESD gets worse in a dry environment)

Precaution for Use

b. EOS (Electrical Over Stress)

Electrical Over-Stress (EOS) is defined as damage that may occur when an electronic device is subjected to a current or voltage that is beyond the maximum specification limits of the device.

The effects from an EOS event can be noticed through product performance like:

- Changes to the performance of the LED package
(If the damage is around the bond pad area and since the package is completely encapsulated the package may turn on but flicker show severe performance degradation.)
- Changes to the light output of the luminaire from component failure
- Components on the board not operating at determined drive power

Failure of performance from entire fixture due to changes in circuit voltage and current across total circuit causing trickle down failures. It is impossible to predict the failure mode of every LED exposed to electrical overstress as the failure modes have been investigated to vary, but there are some common signs that will indicate an EOS event has occurred:

- Damaged may be noticed to the bond wires (appearing similar to a blown fuse)
- Damage to the bond pads located on the emission surface of the LED package
(shadowing can be noticed around the bond pads while viewing through a microscope)
- Anomalies noticed in the encapsulation and phosphor around the bond wires
- This damage usually appears due to the thermal stress produced during the EOS event

c. To help minimize the damage from an EOS event Seoul Semiconductor recommends utilizing:

- A surge protection circuit
- An appropriately rated over voltage protection device
- A current limiting device



Company Information

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Company Information

Seoul Semiconductor (www.SeoulSemicon.com) manufactures and packages a wide selection of light emitting diodes (LEDs) for the automotive, general illumination/lighting, Home appliance, signage and back lighting markets. The company is the world's fifth largest LED supplier, holding more than 10,000 patents globally, while offering a wide range of LED technology and production capacity in areas such as "nPola", "Acrich", the world's first commercially produced AC LED, and "Acrich MJT - Multi-Junction Technology" a proprietary family of high-voltage LEDs.

The company's broad product portfolio includes a wide array of package and device choices such as Acrich and Acirch2, high-brightness LEDs, mid-power LEDs, side-view LEDs, and through-hole type LEDs as well as custom modules, displays, and sensors.

Legal Disclaimer

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